Notice of References Cited Application/Control No. 10/578,229 Examiner Helene Klemanski Applicati(s)/Patent Under Reexamination TAGUCHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0135649 A1	09-2002	Yoshizawa et al.	347/100
*	В	US-2005/0243151 A1	11-2005	Chino et al.	347/100
*	C	US-7,029,523 B2	04-2006	Taguchi et al.	106/31.46
*	D	US-7,048,790 B2	05-2006	Taguchi et al.	106/31.46
*	Е	US-7,037,365 B2	05-2006	Taguchi et al.	106/31.46
*	F	US-7,083,664 B2	08-2006	Taguchi et al.	106/31.27
*	G	US-7,208,035 B2	04-2007	Ogawa et al.	106/31.58
*	Ι	US-7,211,133 B2	05-2007	Taguchi, Toshiki	106/31.48
*	I	US-7,220,302 B2	05-2007	Taguchi, Toshiki	106/31.46
*	J	US-7,252,707 B2	08-2007	Ozawa et al.	106/31.27
*	K	US-7,267,715 B2	09-2007	Taguchi et al.	106/31.48
*	L	US-7,273,519 B2	09-2007	Taguchi et al.	106/31.46
*	М	US-7,303,272 B2	12-2007	Taguchi et al.	106/31.46

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	WO 2004/029166	04-2004	PCT	Taguchi et al.	
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.